

Notice of References Cited	Application/Control No. 10/735,067	Applicant(s)/Patent Under Reexamination MINAMI ET AL.	
	Examiner Mark A. Williams	Art Unit 3676	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,175,990 B1	01-2001	Kato et al.	16/334
	B	US-6,108,868 A	08-2000	Lin, Davys	16/340
	C	US-5,724,683	03-1998	Sorimachi et al.	4/248
	D	US-5,923,751 A	07-1999	Ohtsuka et al.	379/433.13
	E	US-6,065,187 A	05-2000	Mischenko, Nicholas	16/341
	F	US-6,115,886 A	09-2000	Fujita, Oriya	16/330
	G	US-5,905,796 A	05-1999	Jung, Jong-Gab	379/433.13
	H	US-5,970,819 A	10-1999	Kato, Hideo	74/531
	I	US-6,665,907 B1	12-2003	Lu, Sheng-Nan	16/340
	J	US-6,671,928 B2	01-2004	Huang, Kuo-Cheng	16/340
	K	US-6,745,436 B2	06-2004	Kim, Sang-Hyun	16/330
	L	US-5,208,944 A	05-1993	Lu, Sheng N.	16/278
	M	US-6,038,739 A	03-2000	Kato, Hideo	16/342

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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